SN54AHC574...J OR W PACKAGE SN74AHC574...DB, DGV, DW, N, OR PW PACKAGE

(TOP VIEW)

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- *EPIC*[™] (Enhanced-Performance Implanted CMOS) Process
- Operating Range 2-V to 5.5-V V_{CC}
- 3-State Outputs Drive Bus Lines Directly
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

description

The 'AHC574 devices are octal edge-triggered D-type flip-flops that feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. These devices are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels of the data (D) inputs.

A buffered output-enable (\overline{OE}) input places the eight outputs in either a normal logic state (high or low) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and the increased drive provide the capability to drive bus lines without interface or pullup components.

OE does not affect internal operations of the flip-flop. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54AHC574 is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74AHC574 is characterized for operation from -40° C to 85° C.



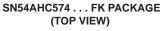
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20 VCC OE 1D 1 2 19 1Q 2D 🛛 3 18 2Q 3D 🛛 4 17 3Q 4D 🛛 5 16 4Q 5D 🛛 6 15 5Q 6D 🛛 7 14 6Q 13 7Q 7D 🛛 8 12 8Q 8D 🛛 9 11 CLK GND [10

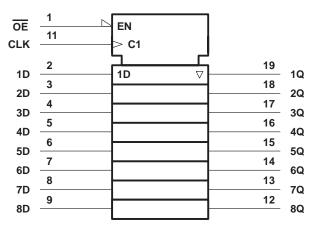


	20 20 10 20 10 20	
3D 4D 5D 6D 7D		2Q 3Q 4Q 5Q 6Q
	CLK 2 0 0 0 2 0 0 0 2 0 0 0 2 0 0 2 0 0 2 0 0 2 0 2	

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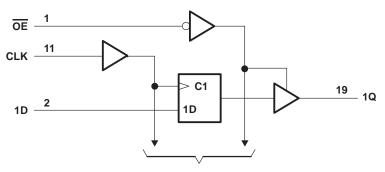
	FUNCTION TABLE (each flip-flop)											
	INPUTS		OUTPUT									
OE	CLK	D	Q									
L	\uparrow	Н	Н									
L	\uparrow	L	L									
L	H or L	Х	Q ₀									
Н	Х	Х	Z									

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



To Seven Other Channels



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Input voltage range, V _I (see Note 1) Output voltage range, V _O (see Note 1) Input clamp current, I_{IK} (V _I < 0) Output clamp current, I_{OK} (V _O < 0 or V _O > V _O Continuous output current, I_O (V _O = 0 to V _{CC}) Continuous current through V _{CC} or GND	-0.5 V to 7 V -0.5 V to 7 V -0.5 V to 7 V -0.5 V to V _{CC} + 0.5 V -20 mA 20 mA ±20 mA ±25 mA ±75 mA 2): DB package 70°C/W DGV package 92°C/W DW package 58°C/W N package 69°C/W
	N package 69°C/W
	PW package
Storage temperature range, T _{stg}	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 3)

			SN54A	SN54AHC574 SN74AHC574			UNIT
			MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage		2	5.5	2	5.5	V
		V _{CC} = 2 V	1.5		1.5		
VIH	High-level input voltage	V _{CC} = 3 V	2.1		2.1		V
		V _{CC} = 5.5 V	3.85		3.85		
		V _{CC} = 2 V		0.5		0.5	
VIL	/IL Low-level input voltage	V _{CC} = 3 V		0.9		0.9	V
		V _{CC} = 5.5 V		1.65		1.65	
VI	Input voltage		0	5.5	0	5.5	V
VO	Output voltage		0	VCC	0	VCC	V
		V _{CC} = 2 V		-50		-50	μA
IОН	High-level output current	V_{CC} = 3.3 V ± 0.3 V		-4		-4	mA
		V_{CC} = 5 V ± 0.5 V		-8		-8	mA
		V _{CC} = 2 V		50		50	μA
IOL	Low-level output current	V_{CC} = 3.3 V ± 0.3 V		4		4	mA
		V_{CC} = 5 V ± 0.5 V		8		8	mA
A+/Ax/	Input transition rise or fell rate	V_{CC} = 3.3 V ± 0.3 V		100		100	ns/V
$\Delta t / \Delta v$	Input transition rise or fall rate	V_{CC} = 5 V ± 0.5 V		20		20	IIS/V
T _A	Operating free-air temperature		-55	125	-40	85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Vee	T	ן = 25°C	;	SN54A	HC574	SN74A	HC574	LINUT
PARAMETER	TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
		2 V	1.9	2		1.9		1.9		
	I _{OH} = -50 μA	3 V	2.9	3		2.9		2.9		
VOH		4.5 V	4.4	4.5		4.4		4.4		V
	I _{OH} = -4 mA	3 V	2.58			2.48		2.48		
	I _{OH} = -8 mA	4.5 V	3.94			3.8		3.8		
		2 V			0.1		0.1		0.1	
	I _{OL} = 50 μA	3 V			0.1		0.1		0.1	
VOL		4.5 V			0.1		0.1		0.1	V
	I _{OL} = 4 mA	3 V			0.36		0.5		0.44	
	I _{OL} = 8 mA	4.5 V			0.36		0.5		0.44	
lj	$V_{I} = V_{CC} \text{ or } GND$	0 V to 5.5 V			±0.1		±1*		±1	μA
I _{OZ}	$V_{O} = V_{CC} \text{ or } GND$	5.5 V			±0.25		±2.5		±2.5	μA
ICC	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.5 V			4		40		40	μΑ
Ci	$V_I = V_{CC}$ or GND	5 V		3	10				10	pF
Co	$V_{O} = V_{CC}$ or GND	5 V		3						pF

* On products compliant to MIL-PRF-38535, this parameter is not production tested at V_{CC} = 0 V.

timing requirements over recommended operating free-air temperature range, $V_{CC} = 3.3 V \pm 0.3 V$ (unless otherwise noted) (see Figure 1)

		T _A = 25°C		SN54A	HC574	SN74AI	UNIT	
		MIN	MAX	MIN	MAX	MIN	MAX	UNIT
tw	Pulse duration, CLK high or low	5		5		5		ns
t _{su}	Setup time, data before CLK1	3.5		3.5		3.5		ns
t _h	Hold time, data after CLK↑	1.5		1.5		1.5		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

		T _A = 25°C		°C SN54AHC574			SN74AHC574		
		MIN	MAX	MIN	MAX	MIN	MAX	UNIT	
tw	Pulse duration, CLK high or low	5		5		5		ns	
t _{su}	Setup time, data before CLK1	3		3		3		ns	
th	Hold time, data after CLK↑	1.5		1.5		1.5		ns	



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switching characteristics over recommended operating free-air temperature range,
V_{CC} = 3.3 V ± 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	T	₄ = 25°C	;	SN54A	HC574	SN74A	HC574	UNIT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
f			C _L = 15 pF	80*	125*		65*		65		MHz
fmax			C _L = 50 pF	50	75		45		45		IVITIZ
^t PLH	CLK	Q	$C_{1} = 15 \text{ pF}$		8.5*	13.2*	1*	15.5*	1	15.5	ns
^t PHL	ULK	Q	C _L = 15 pF		8.5*	13.2*	1*	15.5*	1	15.5	115
^t PZH	OE	Q	C _I = 15 pF		8.2*	12.8*	1*	15*	1	15	ns
^t PZL	OE	Q	CL = 15 pr		8.2*	12.8*	1*	15*	1	15	115
^t PHZ	OE	Q	C _I = 15 pF		8.5*	13*	1*	15*	1	15	ns
^t PLZ	OE	ý	0 <u>[</u> = 15 pi		8.5*	13*	1*	15*	1	15	115
^t PLH	CLK	Q	C _L = 50 pF		11	16.7	1	19	1	19	ns
^t PHL	OLK	y y	CL = 30 pr		11	16.7	1	19	1	19	115
^t PZH	OE	Q	C _L = 50 pF		10.7	16.3	1	18.5	1	18.5	ns
^t PZL	OE	y y	CL = 30 pr		10.7	16.3	1	18.5	1	18.5	115
^t PHZ	OE	Q	C _I = 50 pF		11	15	1	17	1	17	ns
^t PLZ	UE	Q	0L = 30 pr		11	15	1	17	1	17	115
^t sk(o)			C _L = 50 pF			1.5**				1.5	ns

* On products compliant to MIL-PRF-38535, this parameter is not production tested.

** On products compliant to MIL-PRF-38535, this parameter does not apply.

switching characteristics over recommended operating free-air temperature range,
$V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	T	ן = 25°C	;	SN54A	HC574	SN74A	HC574	UNIT
FARAIVIETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
f			C _L = 15 pF	130*	180*		110*		110		MHz
fmax			CL = 50 pF	85	115		75		75		IVITIZ
^t PLH	CLK	Q	C _I = 15 pF		5.6*	8.6*	1*	10*	1	10	ns
^t PHL	ULK	Q	CL = 15 pr		5.6*	8.6*	1*	10*	1	10	115
^t PZH	OE	Q	C _I = 15 pF		5.9*	9*	1*	10.5*	1	10.5	ns
t _{PZL}	OE	ý	0L = 13 pr		5.9*	9*	1*	10.5*	1	10.5	115
^t PHZ	OE	Q	C _I = 15 pF		5.5*	9*	1*	10.5*	1	10.5	ns
^t PLZ	OE	ý	0L = 13 pr		5.5*	9*	1*	10.5*	1	10.5	115
^t PLH	CLK	Q	C _L = 50 pF		7.1	10.6	1	12	1	12	ns
^t PHL	OLK	ý	CL = 30 pr		7.1	10.6	1	12	1	12	115
^t PZH	OE	Q	C _I = 50 pF		7.4	11	1	12.5	1	12.5	ns
tPZL	UE	Ŷ	0L = 00 hr		7.4	11	1	12.5	1	12.5	115
^t PHZ	OE	Q	C ₁ = 50 pF		7.1	10.1	1	11.5	1	11.5	ns
t _{PLZ}	UE	3	0L = 30 bi		7.1	10.1	1	11.5	1	11.5	115
^t sk(o)			C _L = 50 pF			1**				1	ns

* On products compliant to MIL-PRF-38535, this parameter is not production tested.

** On products compliant to MIL-PRF-38535, this parameter does not apply.



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noise characteristics, V_{CC} = 5 V, C_L = 50 pF, T_A = 25^{\circ}C (see Note 4)

SN74A	SN74AHC574		
MIN	MAX	UNIT	
	0.8	V	
	-0.8	V	
4.2		V	
3.5		V	
	1.5	V	
-	4.2	MIN MAX 0.8 -0.8 4.2 3.5	

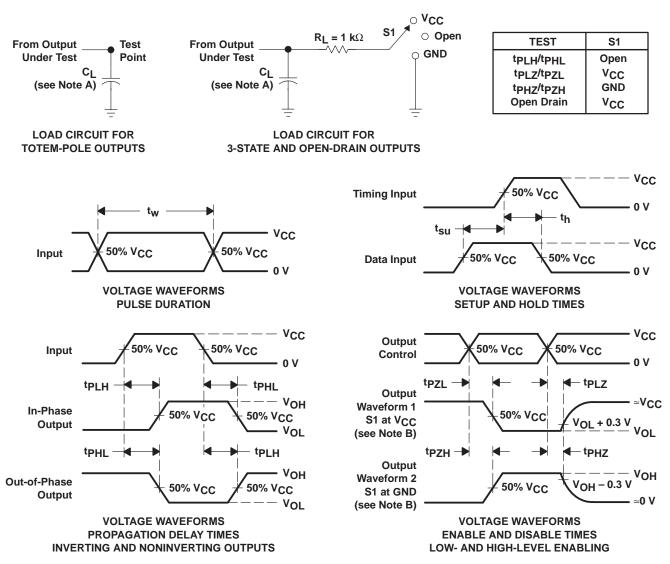
NOTE 4: Characteristics are for surface-mount packages only.

operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd} Power dissipation capacitance	No load, f = 1 MHz	28	pF



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PARAMETER MEASUREMENT INFORMATION

NOTES: A. C₁ includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_f \leq 3 ns, t_f \leq 3 ns.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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